

# FDB047N10 N-Channel PowerTrench<sup>®</sup> MOSFET 100 V, 164 A, 4.7 m $\Omega$

### Features

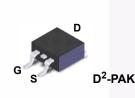
- $R_{DS(on)}$  = 3.9 m $\Omega$  (Typ.) @ V<sub>GS</sub> = 10 V, I<sub>D</sub> = 75 A
- · Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extremely Low  $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- RoHS Compliant

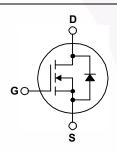
# Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

## Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies
- Micro Solar Inverter





### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol		Parameter		FDB047N10	Unit
V <sub>DSS</sub>	Drain to Source Voltag	100	V		
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
ID	Drain Current	con Limited)	164*	Α	
		116*	Α		
		120	Α		
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	656*	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		1153	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns	
P <sub>D</sub>	Dower Dissinction	(T <sub>C</sub> = 25 <sup>o</sup> C)		375	W
	Power Dissipation	- Derate Above 25°C		2.5	W/ºC
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +175	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C

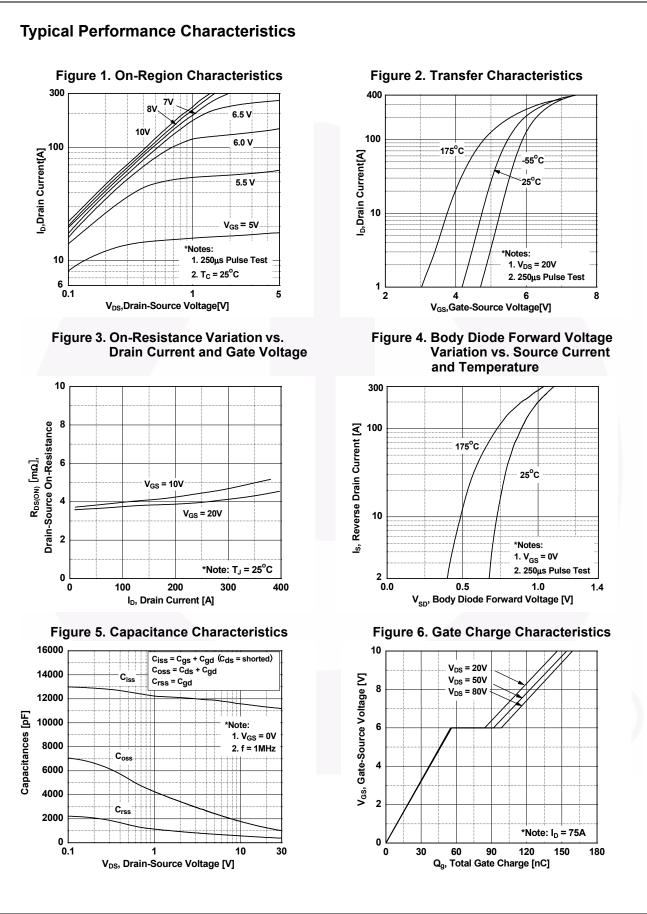
\*Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

# **Thermal Characteristics**

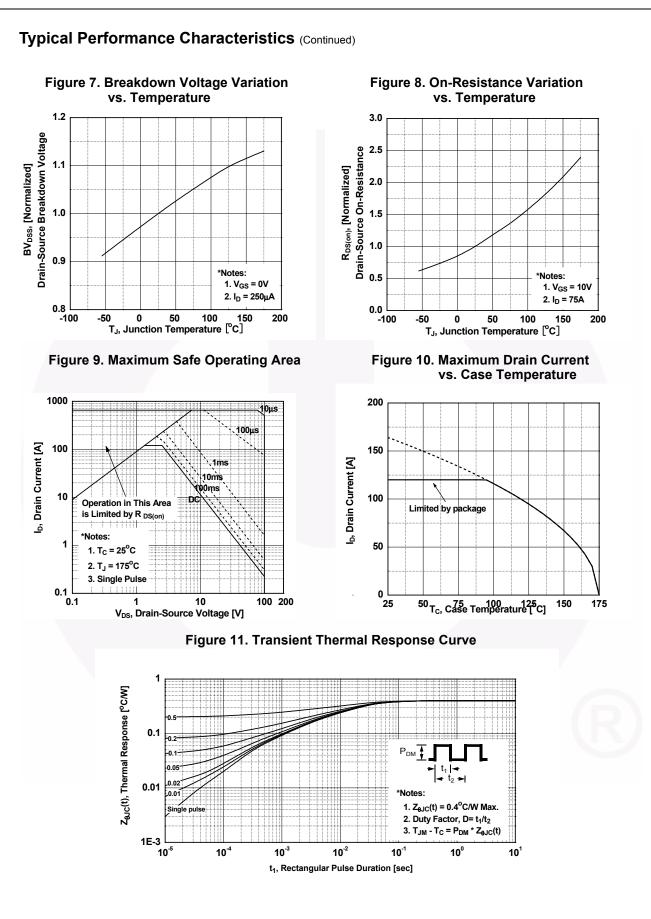
Symbol	Parameter	FDB047N10	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	0.4	
D	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient (1 in <sup>2</sup> Pad of 2-oz Copper), Max.	40	

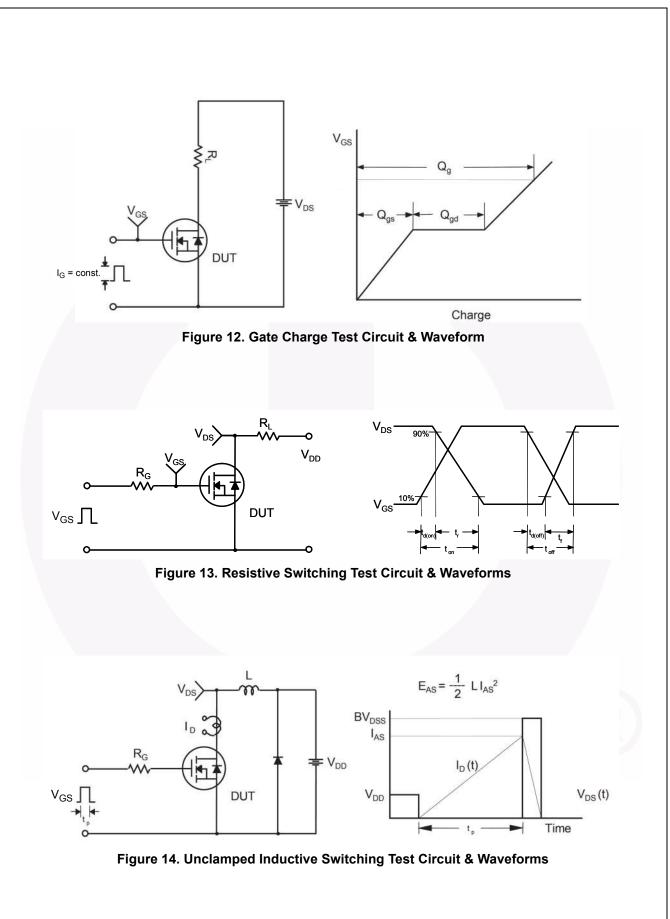
November 2013

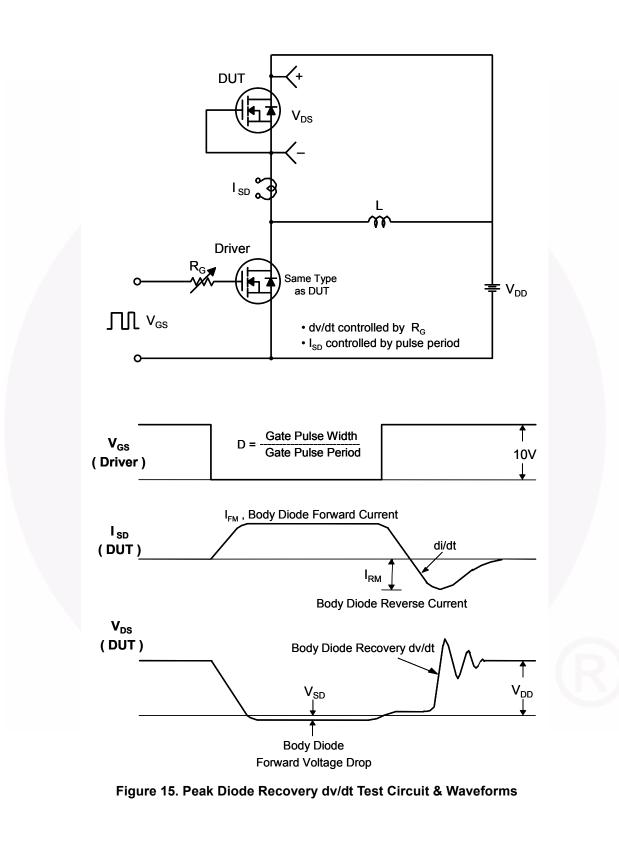
nber	Top Mark	Package	Packing Method	Reel Size	Тар	e Width	Qua	ntity
•		D <sup>2</sup> -PAK	Tape and Reel	330 mm			800 units	
I Chara	cteristics T <sub>C</sub> = 25°C	C unless oth	nerwise noted.					
	Parameter		Test Conditio	ns	Min.	Тур.	Max.	Unit
teristics								
Drain to S	Source Breakdown Voltag	e Ir	<sub>0</sub> = 250 μA, V <sub>GS</sub> = 0 V,	T <sub>.1</sub> = 25 <sup>o</sup> C	100	-	-	V
Breakdown Voltage Temperature Coefficient			$I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ C		-	0.1	-	V/ºC
Zero Gat	e Voltage Drain Current				-	-	1	μA
Zero Gate voltage Drain Current			$V_{DS}$ = 100 V, $V_{GS}$ = 0 V, $T_{C}$ = 150°C		-	-	500	μΑ
Gate to Body Leakage Current		V	v <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V		-	-	±100	nA
teristics								
Gate Thr	eshold Voltage	V	/ <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA		2.5	3.5	4.5	V
Static Dra	ain to Source On Resistar				-	3.9	4.7	mΩ
Forward	Transconductance				-	170	-	S
haracter	ristics							
-					-	11500	15265	pF
				-	1120	1500	pF	
		t		-	455	680	pF	
		V <sub>DD</sub> = 50 V. I <sub>D</sub> = 75 A.		-	174	358	ns	
	,			-			ns	
			$V_{GS} = 10 \text{ V}, \text{ R}_{G} = 25 \Omega$		-			ns
					-		499	ns
				( ,	-	160	210	nC
	-			_	-	56	-	nC
			GS TO V	(Note 4)	-	36	-	nC
ce Diod	e Characteristics	I		<u>I</u>		1		
Maximum	Continuous Drain to Sou	rce Diode F	orward Current		-	-	164*	Α
Maximum	Pulsed Drain to Source I	Diode Forwa	ard Current		-	-	656	Α
					-	-	1.25	V
Reverse I	Recovery Time		V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 75 A,		-	88	-	ns
Reverse I	Recovery Charge		$dl_{F}/dt = 100 \text{ A}/\mu\text{s}$		-	245	· -	nC
	I Chara teristics Drain to S Breakdow Coefficier Zero Gate Gate to B teristics Gate Thre Static Dra Forward Character Character Turn-On I Turn-On I Turn-Off I	I Characteristics $T_{c} = 25^{\circ}$ Parameter teristics Drain to Source Breakdown Voltag Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate to Body Leakage Current teristics Gate Threshold Voltage Static Drain to Source On Resistar Forward Transconductance Characteristics Input Capacitance Output Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Fall Time Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Tec Diode Characteristics Maximum Continuous Drain to Source I	I Characteristics Parameter   Parameter Interistics   Drain to Source Breakdown Voltage Interistics   Breakdown Voltage Temperature Interistics   Zero Gate Voltage Drain Current V   Gate to Body Leakage Current V   Gate to Body Leakage Current V   teristics Gate Threshold Voltage V   Static Drain to Source On Resistance V   Forward Transconductance V   Characteristics Input Capacitance V   Output Capacitance V   Qutput Capacitance V   Turn-On Delay Time V   Turn-Off Delay Time V   Turn-Off Fall Time V   Gate to Source Gate Charge V   Gate to Drain "Miller" Charge V   Gate to Drain "Miller" Charge V   Maximum Continuous Drain to Source Diode Forward V   Drain to Source Diode Forward Voltage V	I Characteristics T <sub>C</sub> = 25°C unless otherwise noted.   Parameter Test Condition   Steristics ID = 250 $\mu$ A, V <sub>GS</sub> = 0 V, Breakdown Voltage Temperature Coefficient ID = 250 $\mu$ A, Referenced Voltage Drain Current   Zero Gate Voltage Drain Current VDS = 100 V, VGS = 0 V, VDS = 100 V, VDS = 0 V, VDS = 100 V, VDS = 0 V, VDS = 10 V, ID = 75 A, Forward Transconductance   Gate Threshold Voltage VGS = VDS, ID = 250 $\mu$ A   Static Drain to Source On Resistance VGS = 10 V, ID = 75 A   Forward Transconductance VDS = 10 V, ID = 75 A   Characteristics Input Capacitance   Output Capacitance VDS = 25 V, VGS = 0 V, f = 1 MHz   Characteristics VDD = 50 V, ID = 75 A, VGS = 0 V, f = 1 MHz   Turn-On Delay Time VDS = 10 V, RG = 25 Ω   Turn-Off Delay Time VDS = 10 V, RG = 25 Ω   Turn-Off Fall Time VDS = 80 V, ID = 75 A, VGS = 10 V, RG = 25 Ω   Turn-Off Fall Time VDS = 10 V, RG = 25 Ω   Turn-Off Fall Time VDS = 80 V, ID = 75 A, VGS = 10 V   Gate to Drain "Miller" Charge VDS = 80 V, ID = 75 A, VGS = 10 V   Gate to Drain "Miller" Charge VDS = 10 V VD = 75 A, VGS = 10 V   Maximum Continuous Drain to	I Characteristics Test Conditions   Parameter Test Conditions   teristics Into Source Breakdown Voltage Into Source Breakdown Voltage Into Source Breakdown Voltage Into Source Breakdown Voltage Into Source Source Breakdown Voltage Into Source Source Breakdown Voltage Into Source So	I Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.   Parameter Test Conditions Min.   tteristics Ibrain to Source Breakdown Voltage Ib = 250 $\mu$ A, $V_{GS} = 0 V$ , $T_J = 25^{\circ}C$ 100   Breakdown Voltage Temperature Coefficient Ib = 250 $\mu$ A, Referenced to $25^{\circ}C$ -   Zero Gate Voltage Drain Current $V_{DS} = 100 V, V_{GS} = 0 V$ -   Gate to Body Leakage Current $V_{GS} = 20 V, V_{DS} = 0 V$ -   Gate Threshold Voltage $V_{GS} = 220 V, V_{DS} = 0 V$ -   teristics Imput Capacitance $V_{GS} = 100 V, V_{GS} = 0 V, T_C = 150^{\circ}C$ -   Gate Threshold Voltage $V_{GS} = V_{DS}, I_D = 250 \mu$ A 2.5 Static Drain to Source On Resistance $V_{GS} = 10 V, I_D = 75 A$ -   Forward Transconductance $V_{DS} = 10 V, I_D = 75 A$ - -   Output Capacitance $V_{DS} = 25 V, V_{GS} = 0 V, f_D = 75 A, f_D = 10 V, R_G = 25 \Omega$ - -   Turn-On Delay Time $V_{OS} = 10 V, R_G = 25 \Omega$ - - -   Turn-Off Delay Time $V_{OS} = 10 V, R_G = 25 \Omega$ - - -   Turn-Off Delay Time $V_{OS} = 10 V, R_G = 25 \Omega$ - - -	I Characteristics ParameterTest ConditionsMin.Typ.teristicsDrain to Source Breakdown Voltage $I_D = 250 \ \mu$ A, $V_{GS} = 0 \ V, T_J = 25^{\circ}C$ 100-Breakdown Voltage Temperature Coefficient $I_D = 250 \ \mu$ A, Referenced to $25^{\circ}C$ 0.1Zero Gate Voltage Drain Current $V_{DS} = 100 \ V, V_{GS} = 0 \ V$ Gate to Body Leakage Current $V_{GS} = 100 \ V, V_{GS} = 0 \ V, T_C = 150^{\circ}C$ Gate to Body Leakage Current $V_{GS} = 250 \ \mu$ A, $Z_{CS} = 10 \ V, T_{CS} = 100 \ V, T_$	$\begin{tabular}{ c c c c c } \hline I Characteristics $V_C = 25^\circ C unless otherwise noted. $$Win. Typ. Max. $$Teristics $$ $V_C = 25^\circ C unless otherwise noted. $$Win. Typ. Max. $$Teristics $$ $V_C = 25^\circ C unless otherwise noted. $$V_C = 10^\circ C Unless 0^\circ C unless 0$

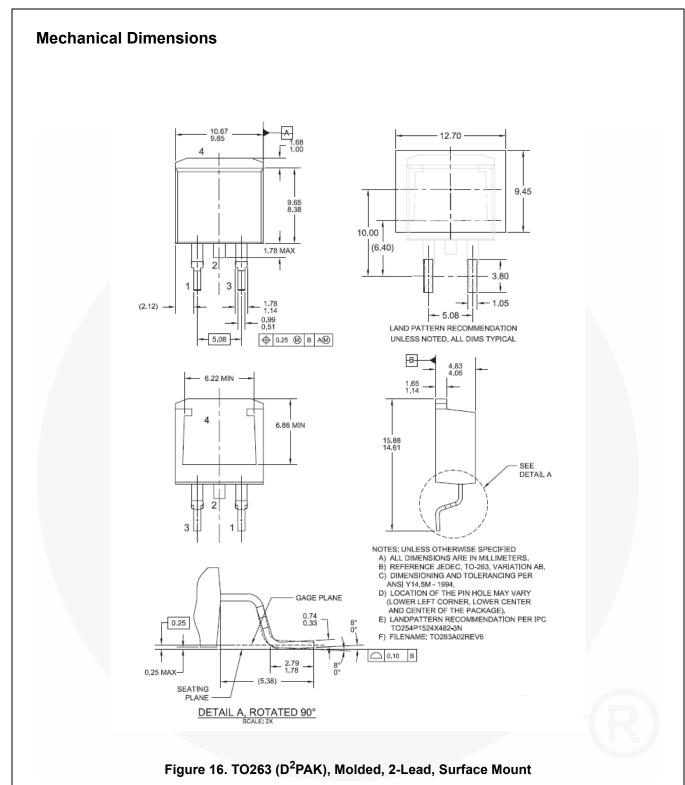


©2008 Fairchild Semiconductor Corporation FDB047N10 Rev. C2









Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a Fairchild Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide terms and conditions, specifically the warranty therein, which covers Fairchild products.

Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings:

http://www.fairchildsemi.com/package/packageDetails.html?id=PN\_TT263-0R2



SEMICONDUCTOR

### TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

intended to be an exhaustive list of	an such trauemarks.		
AccuPower <sup>TM</sup> AX-CAP <sup>®*</sup> BitSiC <sup>TM</sup> Build it Now <sup>TM</sup> CorePLUS <sup>TM</sup> CorePOWER <sup>TM</sup> CROSSVOLT <sup>TM</sup> CTL <sup>TM</sup> CUITM CUITM CUITM CUITM CUITM CUITM CUITM CUITM COITM ECOSPARK <sup>®</sup> EfficentMax <sup>TM</sup> ESBC <sup>TM</sup> Fairchild <sup>®</sup> Fairchild Semiconductor <sup>®</sup> FACT <sup>®</sup> FAST <sup>®</sup> FastvCore <sup>TM</sup>	F-PFS™ FRFET <sup>®</sup> Global Power Resource <sup>SM</sup> Green FPS™ Green FPS™ e-Series™ Gmax™ GTO™ IntelliMAX™ ISOPLANAR™ Marking Small Speakers Sound Lou and Better™ MegaBuck™ MICROCOUPLER™ MicroPat™ MicroPat™ MicroPat™ MicroPak2 MicroPak2	Saving our world, 1mW/W/kW at a time™ SignalWise™ SmartMax™ SMART START™ Solutions for Your Success™ SPM <sup>®</sup> STEALTH™ SuperFET <sup>®</sup> SuperSOT™-3 SuperSOT™-6 SuperSOT™-8	Sync-Lock <sup>™</sup> <b>EGENERAL</b> TinyBoost <sup>®</sup> TinyDost <sup>®</sup> TinyCalc <sup>™</sup> TinyCalc <sup>™</sup> TinyOPTO <sup>™</sup> TinyPWM <sup>™</sup> TinyPWM <sup>™</sup> TinyPWM <sup>™</sup> TinyPWM <sup>™</sup> TinyUire <sup>™</sup> TinyDWM <sup>™</sup> TinyUire <sup>™</sup> TinyDWM <sup>™</sup> TinyUire <sup>™</sup> TinyDWM <sup>™</sup> TinyUire <sup>™</sup> TinyDWM <sup>™</sup> TinyDWM <sup>™</sup> TinyDWM <sup>™</sup> TinyECURRENT <sup>®</sup> * µSerDes <sup>™</sup> UHC <sup>®</sup> Uitra FRFET <sup>™</sup> VCX <sup>™</sup> VisualWax <sup>™</sup>
FAST®	OptoHiT™	SuperSOT™-6	UniFET™

\*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are 1. intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- 2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

#### PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.